

FIG. 1A

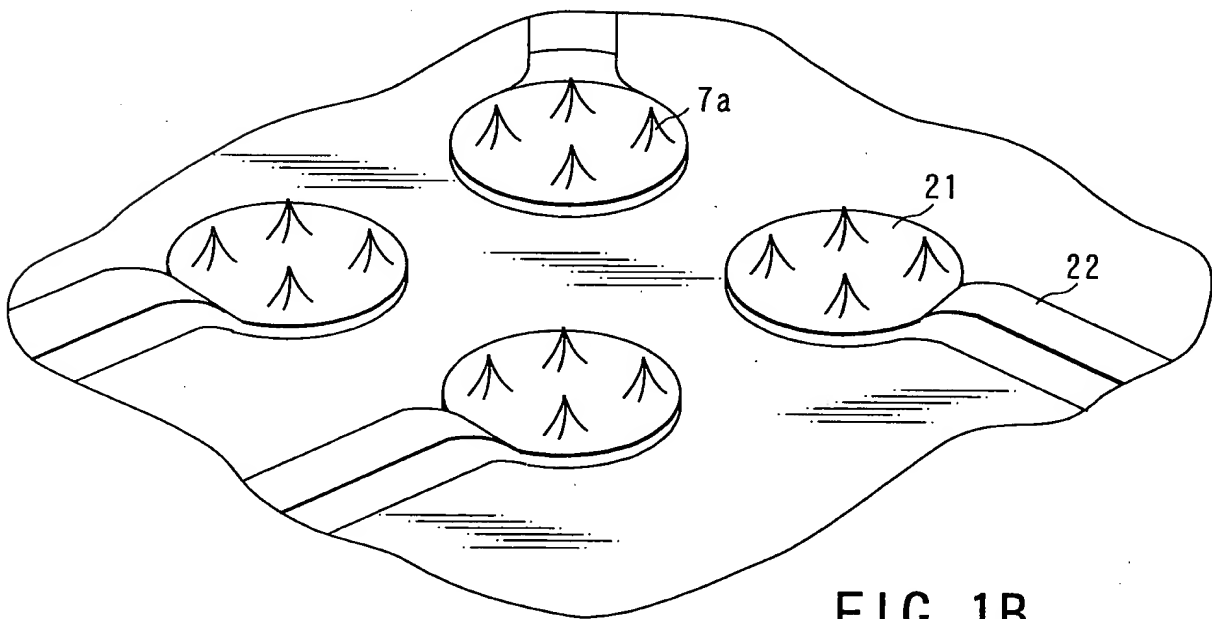


FIG. 1B

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FIG. 2A

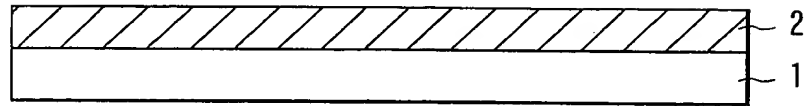


FIG. 2B

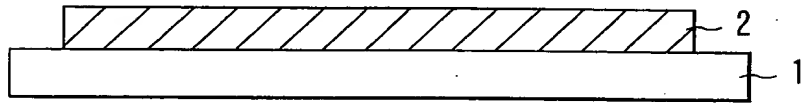


FIG. 2C

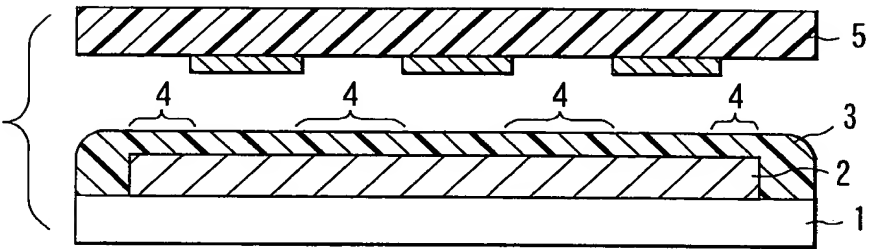


FIG. 2D

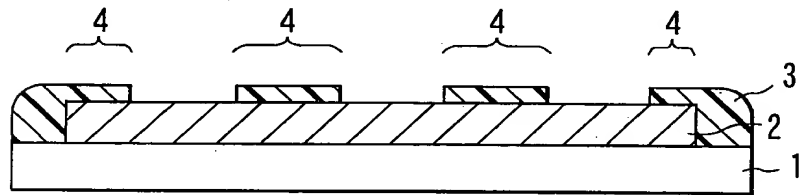


FIG. 2E

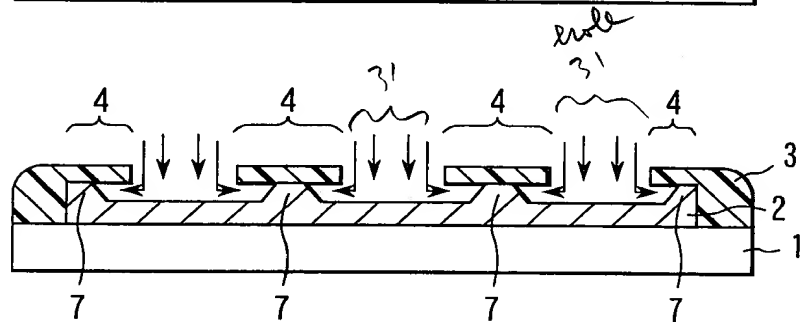


FIG. 2F

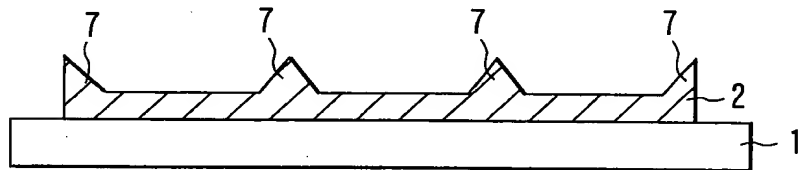


FIG. 2G

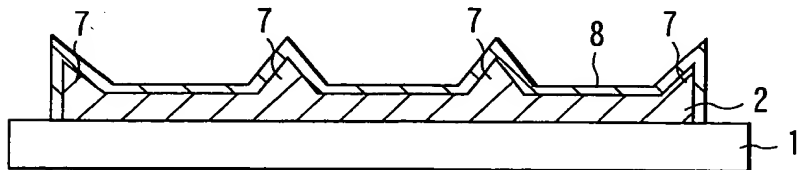


FIG. 2A

APPROVED	Q.G. FIG.
BY	CLASS SUBCLASS
DRAFTSMAN	

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AND APPARATUS FOR TESTING AN ELECTRONIC
COMPONENT
Filed: April 26, 2001
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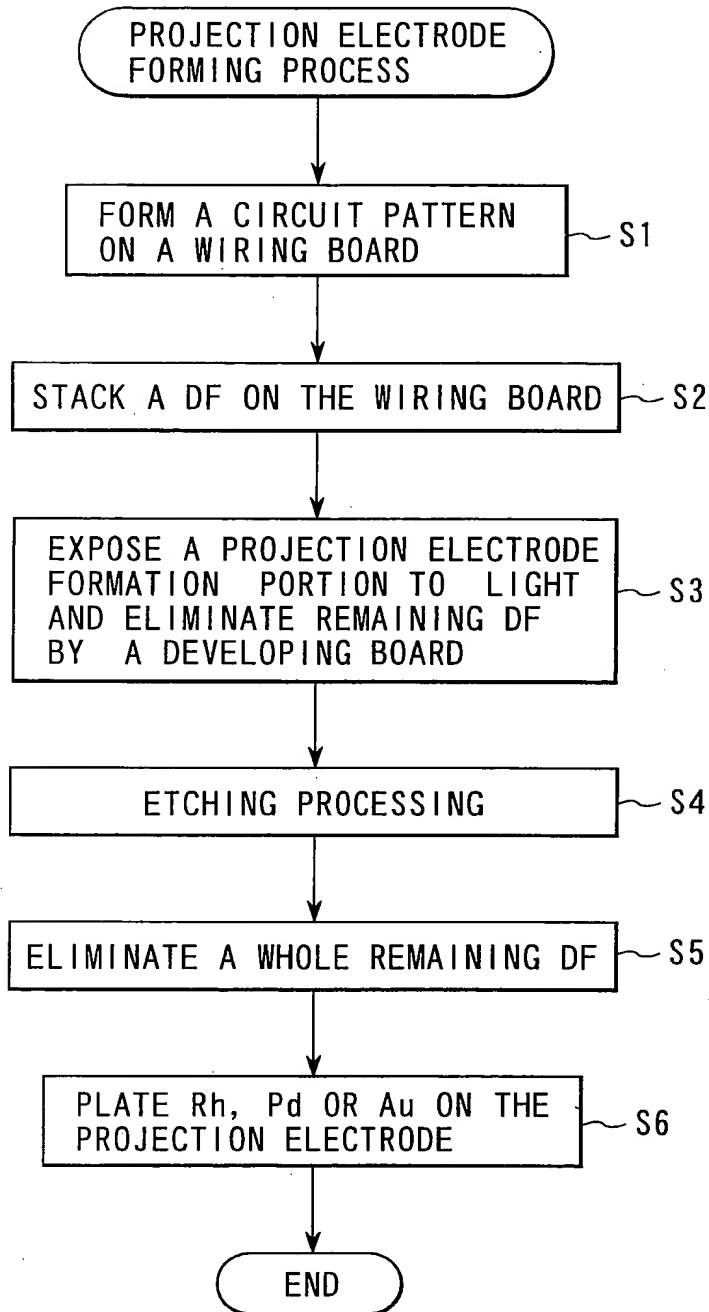


FIG. 3

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FIG. 4

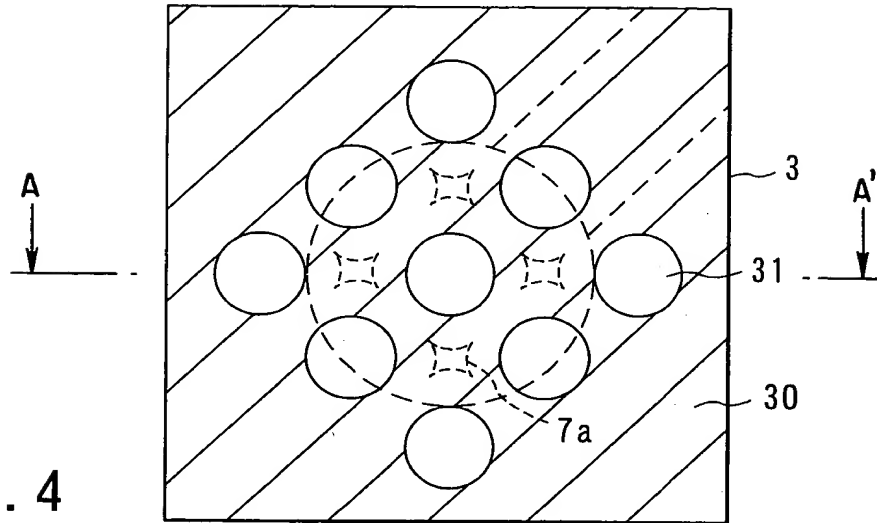
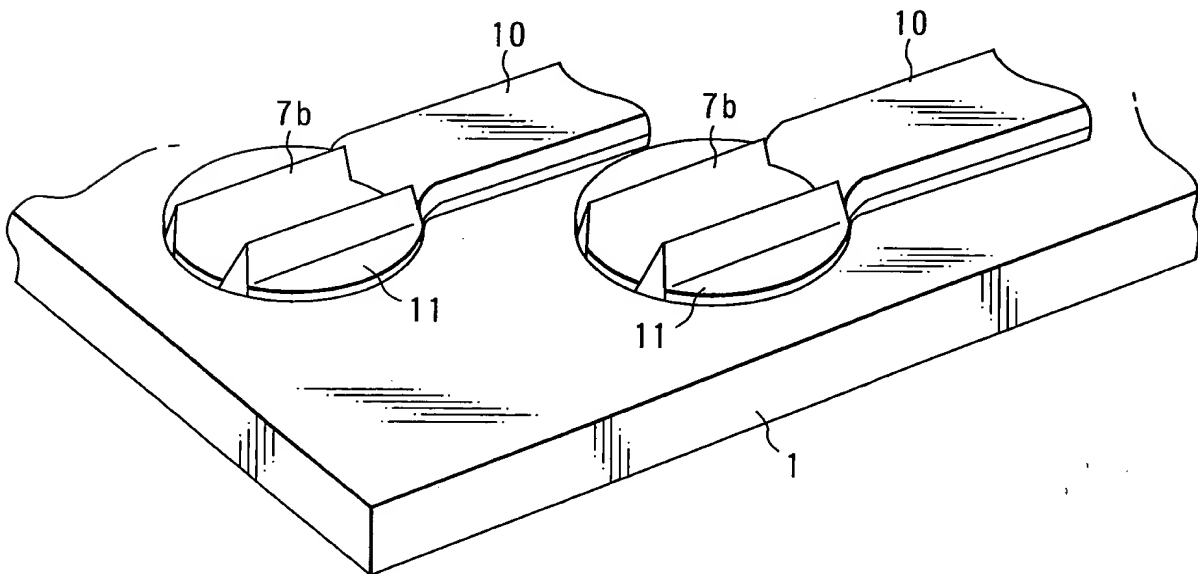


FIG. 5



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FIG. 6

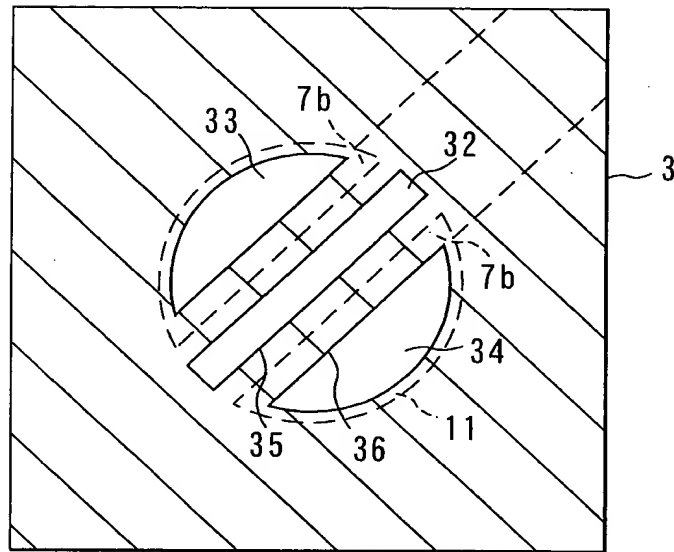
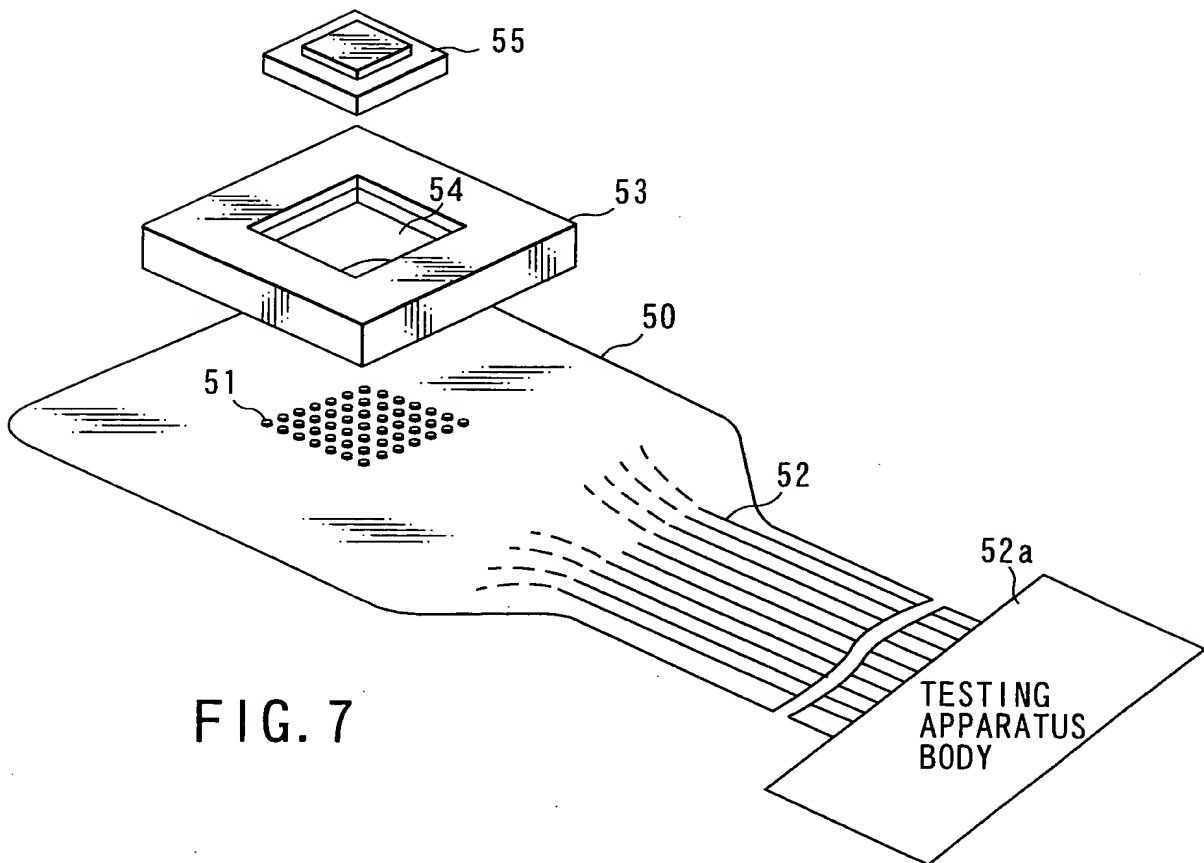


FIG. 7



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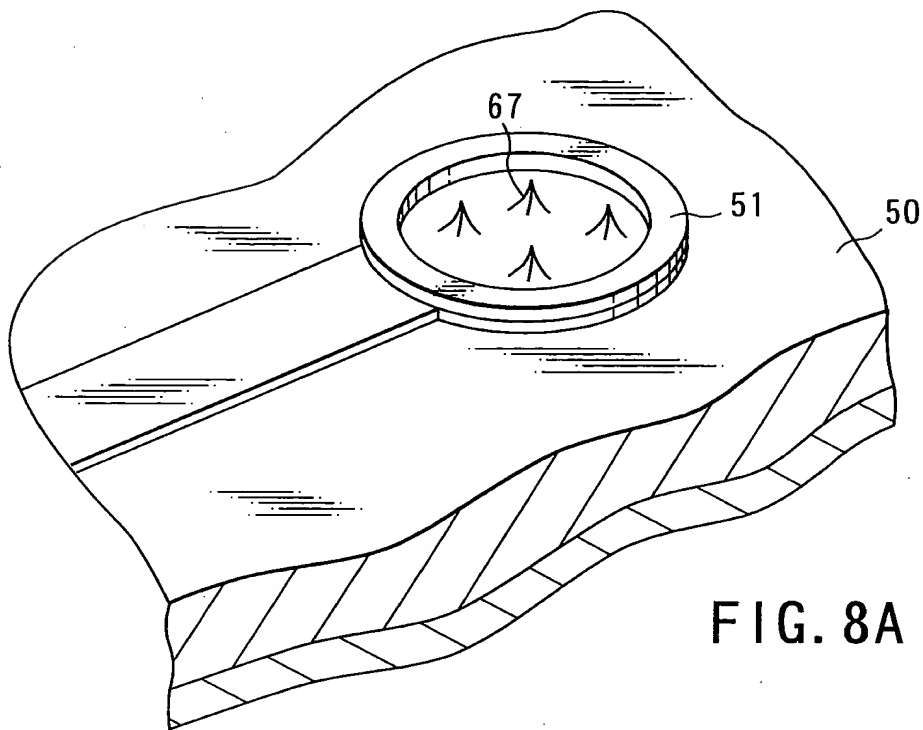


FIG. 8A

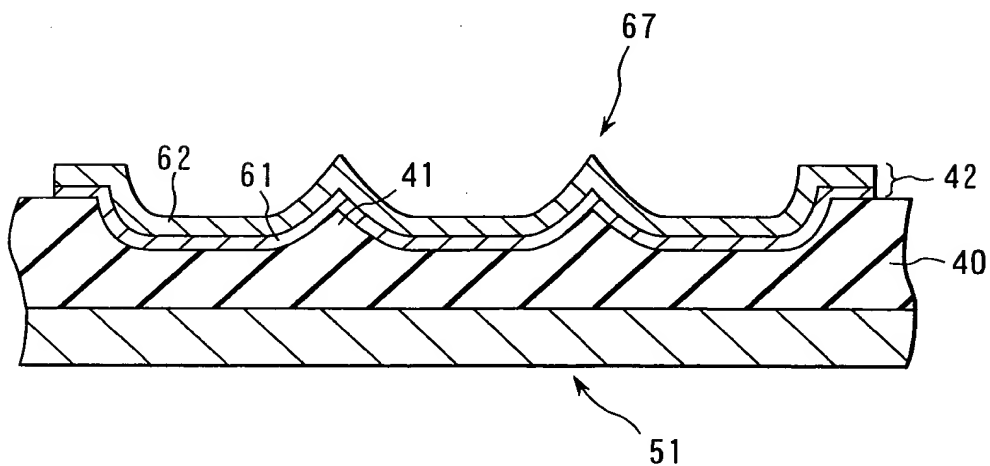


FIG. 8B

109240 24024360

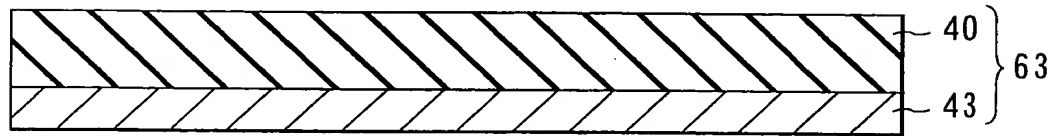


FIG. 9A

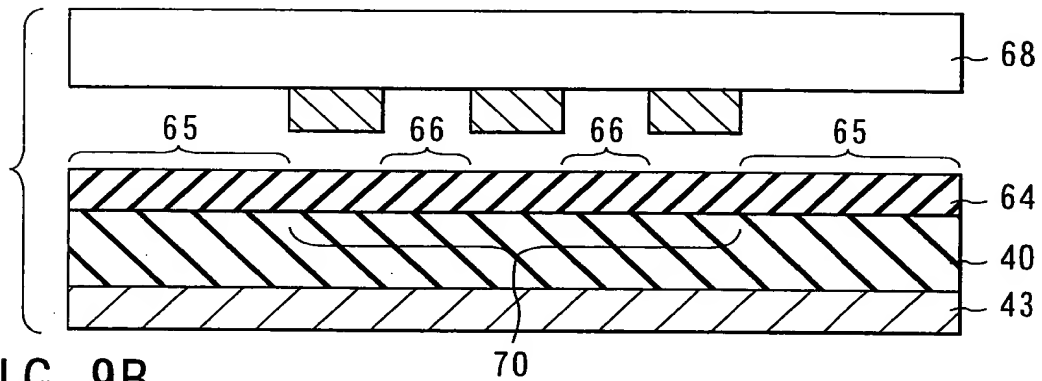


FIG. 9B

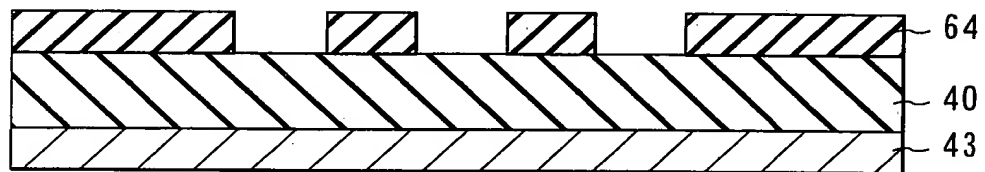


FIG. 9C

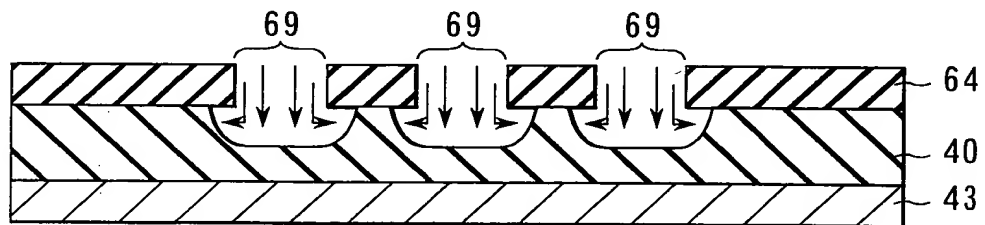


FIG. 9D

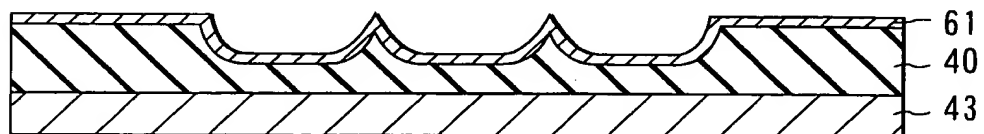


FIG. 9E

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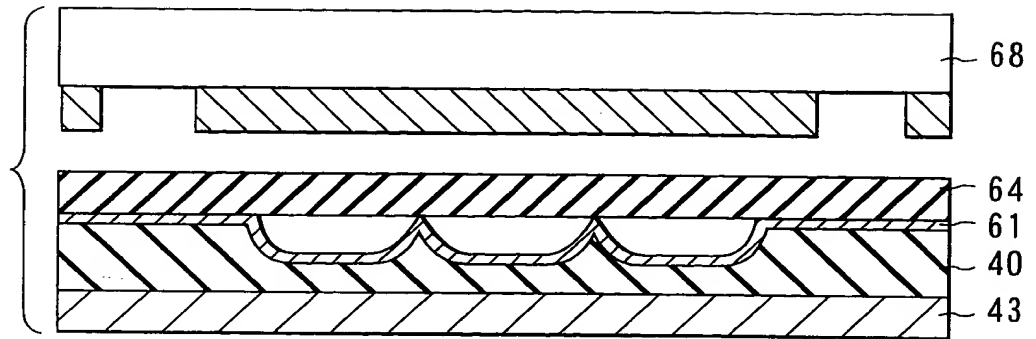


FIG. 9F

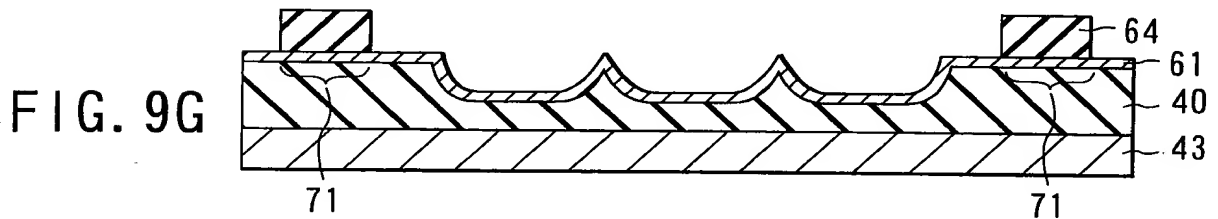


FIG. 9G

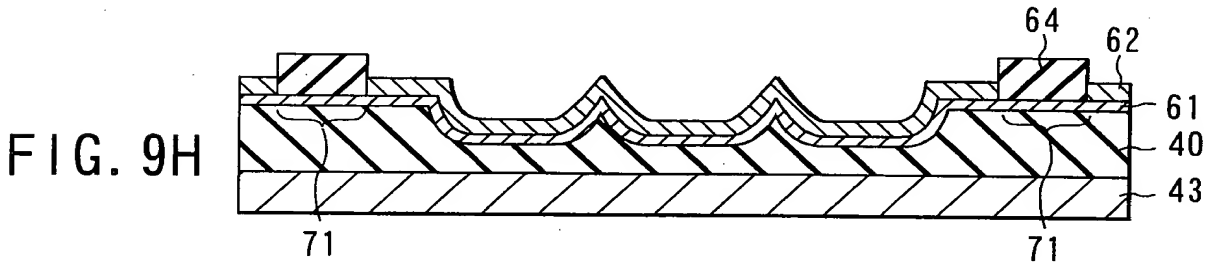


FIG. 9H

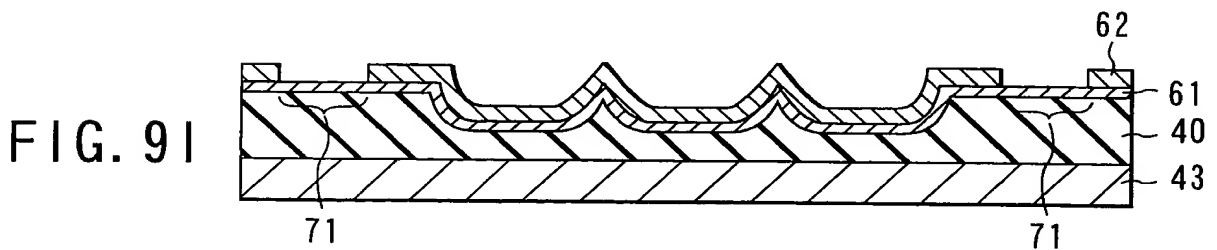


FIG. 9I

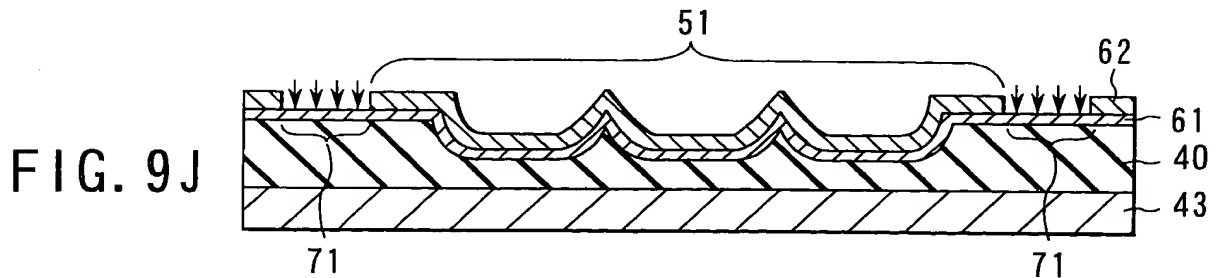


FIG. 9J

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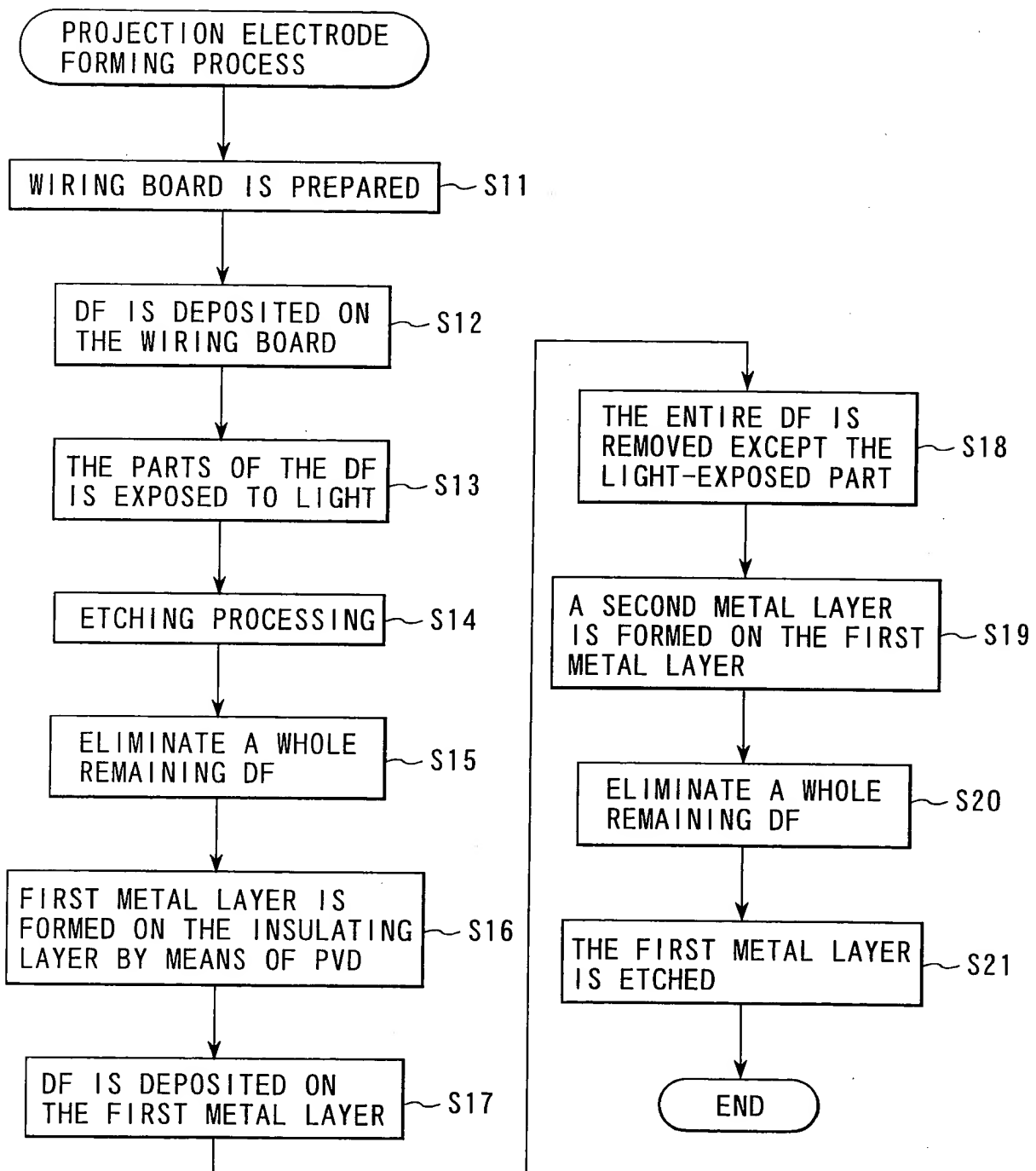


FIG. 10

FIG. 11

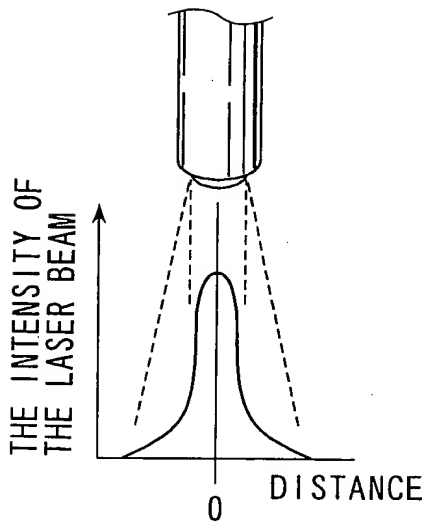
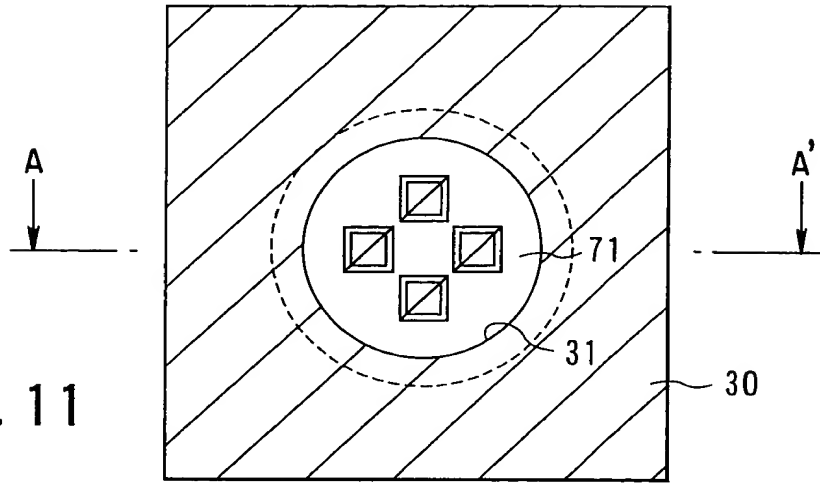


FIG. 12B

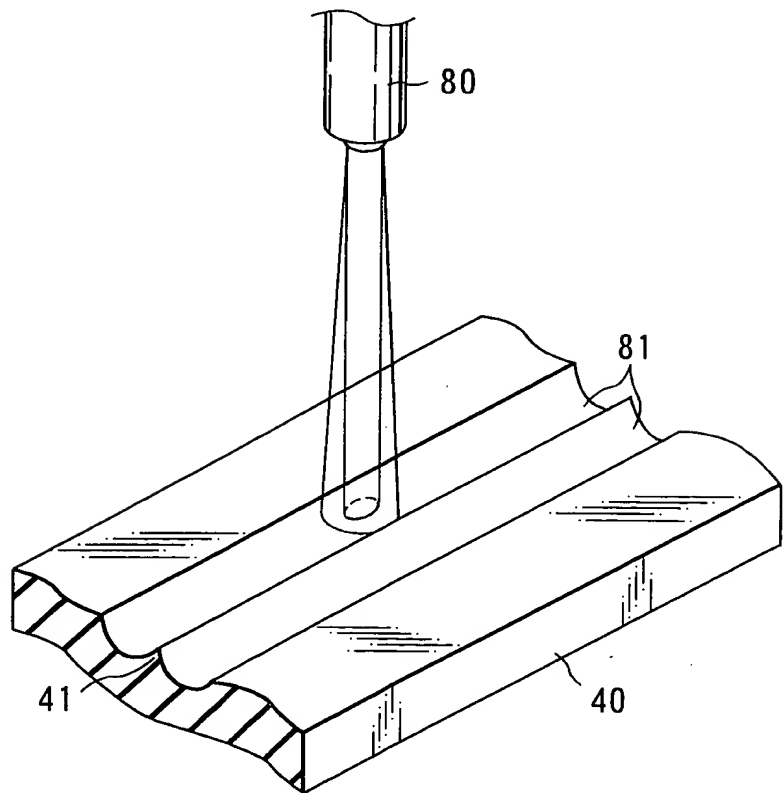


FIG. 12A

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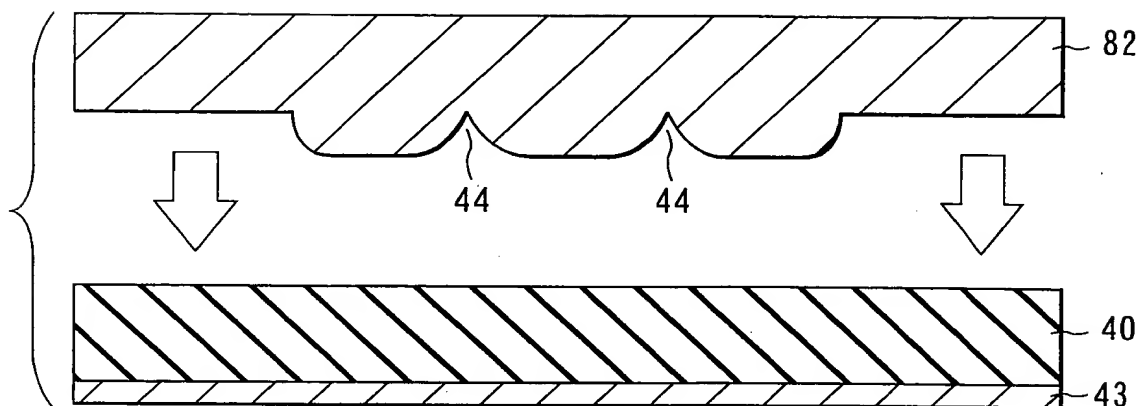


FIG. 13A

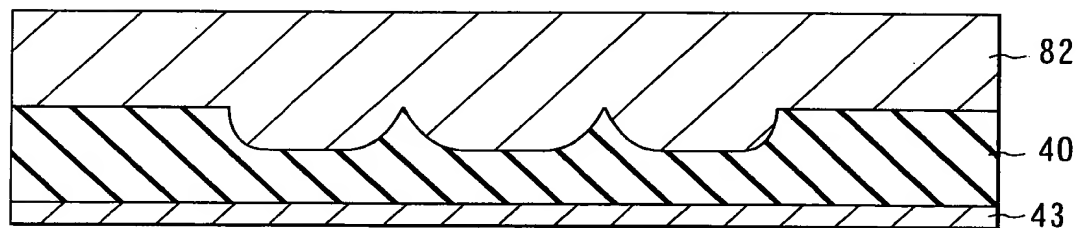


FIG. 13B

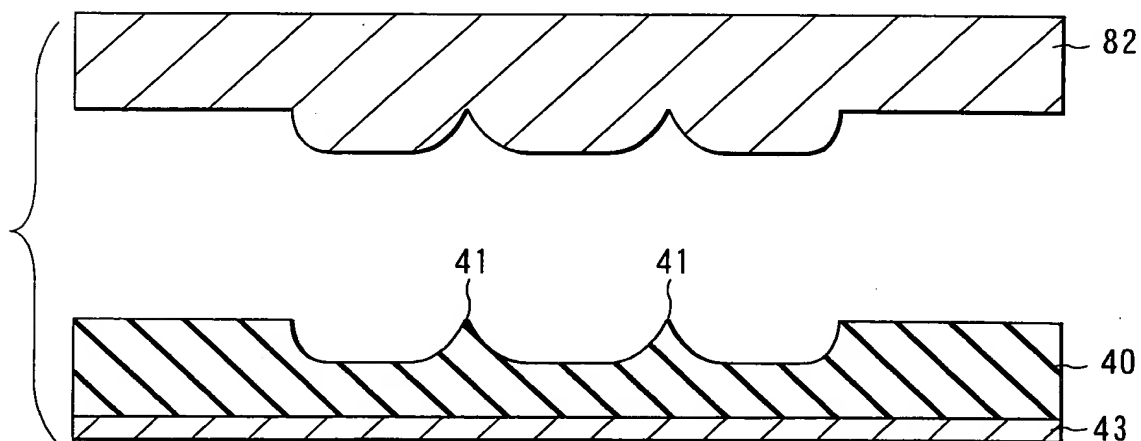


FIG. 13C

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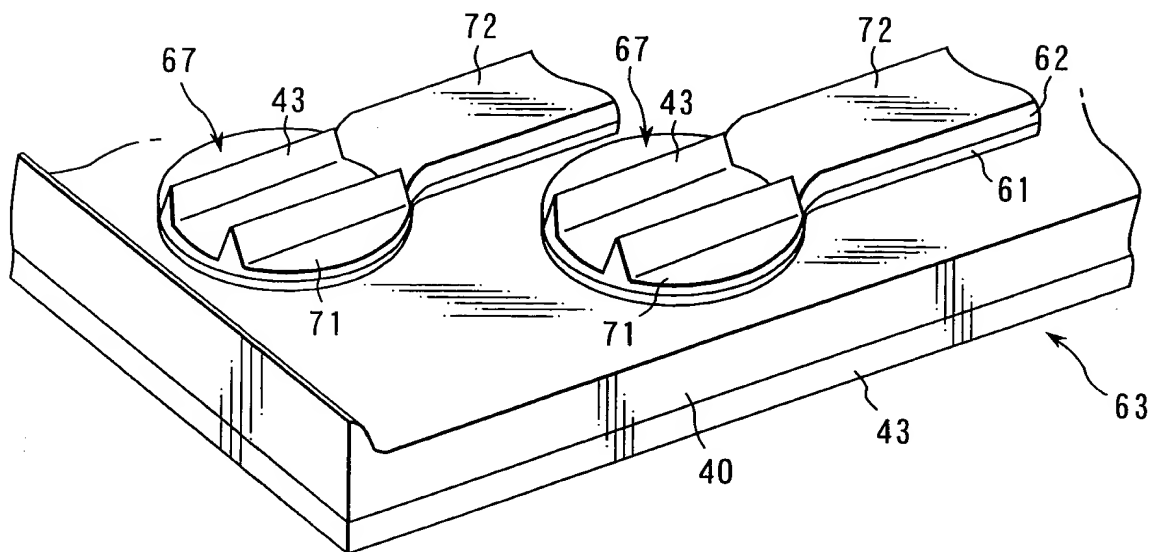


FIG. 14

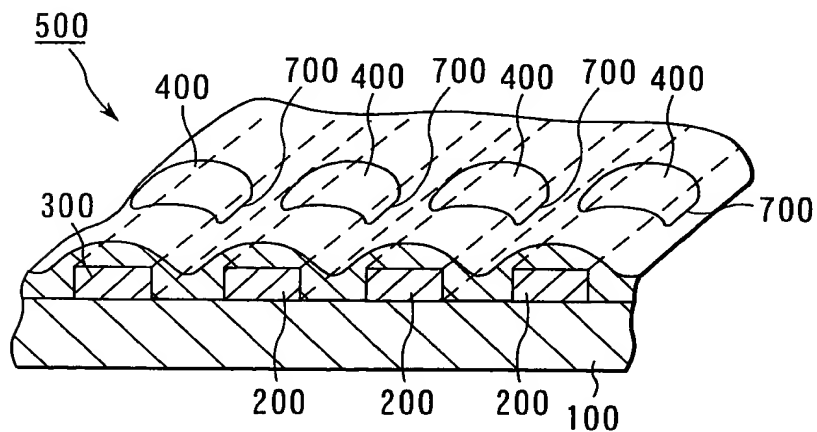


FIG. 15 (PRIOR ART)

FIG. 14